

SLOVENSKI STANDARD oSIST prEN IEC 61000-4-2:2024

01-julij-2024

Elektromagnetna združljivost (EMC) - 4-2. del: Preskusne in merilne tehnike -Preskus odpornosti proti elektrostatični razelektritvi

Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test

Elektromagnetische Verträglichkeit (EMV) - Teil 4-2: Prüf- und Messverfahren - Prüfung der Störfestigkeit gegen die Entladung statischer Elektrizität

Compatibilité électromagnétique (CEM) - Partie 4-2: Techniques d'essai et de mesure - Essai d'immunité aux décharges électrostatiques

Document Preview

Ta slovenski standard je istoveten z: prEN IEC 61000-4-2:2024 oSIST prEN IEC 61000-4-2:2024

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77B/890/CDV

COMMITTEE DRAFT FOR VOTE (CDV)

PROJECT NUMBER:	ECT NUMBER:	
IEC 61000-4-2 ED3		
DATE OF CIRCULATION:	CLOSING DATE FOR VOTING:	
2024-05-03	2024-07-26	
SUPERSEDES DOCUMENTS:		
77B/878/CD, 77B/889/CC		

IEC SC 77B : HIGH FREQUENCY PHENOMENA		
Secretariat:	SECRETARY:	
France	Mr Franck GRUFFAZ	
OF INTEREST TO THE FOLLOWING COMMITTEES:	PROPOSED HORIZONTAL STANDARD:	
TC 44,TC 61,TC 62,SC 65A,TC 66,TC 77,SC		
77A,TC 82,TC 108,TC 124,CIS/B,CIS/F,CIS/I	Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.	
FUNCTIONS CONCERNED:		
EMC ENVIRONMENT	QUALITY ASSURANCE SAFETY	
SUBMITTED FOR CENELEC PARALLEL VOTING	□ NOT SUBMITTED FOR CENELEC PARALLEL VOTING	
	andards	
The attention of IEC National Committees, members of CENELEC, is drawn to the fact that this Committee Draft for Vote (CDV) is submitted for parallel voting	dards.iteh.ai)	
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The CENELEC members are invited to vote through the		

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TITLE:

Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test

PROPOSED STABILITY DATE: 2027

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91 92	INTERNATIONAL ELECTROTECHNICAL COMMISSION
93 94 95	ELECTROMAGNETIC COMPATIBILITY (EMC) –
96 97	Part 4-2: Testing and measurement techniques – Electrostatic discharge immunity test
97 98	Electrostatic discharge minunity test
99	
100	FOREWORD
101 102 103 104 105 106 107 108 109 110	1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with can participate in this preparatory work. International, governmental and non- governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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134 135	International Standard IEC 61000-4-2 has been prepared by subcommittee 77B: High- frequency phenomena, of IEC technical committee 77: Electromagnetic compatibility.
136 137	This third edition cancels and replaces the second edition published in 2008 and constitutes a technical revision.
138 139	It forms Part 4-2 of IEC 61000. It has the status of a basic EMC publication in accordance with IEC Guide 107.
140	The main changes with respect to the second edition of this standard are the following:
141	 Add a calibration requirement for ESD generators with air discharge tip;
142	 Add a normative annex for test setups for specific equipment;
143	 add a test method for wall mounted equipment and wearable devices (see Annex);
144	 add an informative annex for wearable devices;
145 146	 add an informative annex for improvement of how to select test points and give guidance on how to specify the number of pulses for direct contact discharges;

- 147 moving clause 9 into a new informative annex; •
- improvement of the current calibration procedure; 148 •
- improvement of the measurement uncertainty considerations with examples of uncertainty 149 • 150 budgets;
- 151 Because post installation tests cannot be performed in a controlled environment, this test • 152 method has been moved into a new Annex G.
- The text of this standard is based on the following documents: 153

FDIS	Report on voting
77B/xxx/FDIS	77B/xxx/RVD

167 168

155 Full information on the voting for the approval of this standard can be found in the report on 156 voting indicated in the above table.

- 157 This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.
- A list of all parts of the IEC 61000 series, published under the general title Electromagnetic 158 compatibility (EMC), can be found on the IEC website. 159

The committee has decided that the contents of this publication will remain unchanged until 160 the maintenance result date indicated on the IEC web site under "http://webstore.iec.ch" in 161 the data related to the specific publication. At this date, the publication will be 162

- reconfirmed, 163 ٠
- 164 withdrawn, •
- replaced by a revised edition, or amended. 165 •
- 166

- 6 -

169	INTRODUCTION
170	IEC 61000-4 is a part of the IEC 61000 series, according to the following structure:
171	Part 1: General
172	General consideration (introduction, fundamental principles)
173	Definitions, terminology
174	Part 2: Environment
175	Description of the environment
176	Classification of the environment
177	Compatibility levels
178	Part 3: Limits
179	Emission limits
180 181	Immunity limits (in so far as they do not fall under the responsibility of the product committees)
182	Part 4: Testing and measurement techniques
183	Measurement techniques
184	Testing techniques
185	Part 5: Installation and mitigation guidelines
186	Installation guidelines
187	Mitigation methods and devices
188	Part 6: Generic standards
189	Part 9: Miscellaneous

190 Each part is further subdivided into several parts, published either as international standards

191 or as technical specifications or technical reports, some of which have already been published

as sections. Others will be published with the part number followed by a dash and a second

193 number identifying the subdivision (example: IEC 61000-6-1).

194 This part of IEC 61000 is an International Standard which gives immunity requirements and 195 test procedures related to electrostatic discharge.

196

ELECTROMAGNETIC COMPATIBILITY (EMC) -197

Part 4-2: Testing and measurement techniques – Electrostatic discharge immunity test

200 201

198

199

- 202
- 203

204 Scope 1

205 This part of IEC 61000 relates to the immunity requirements and test methods for electrical 206 and electronic equipment subjected to static electricity discharges from operators directly and from personnel to adjacent objects. It additionally specifies ranges of test levels which relate 207 208 to different environmental and installation conditions and establishes test procedures.

209 The object of this standard is to establish a common and reproducible basis for evaluating the performance of electrical and electronic equipment when subjected to electrostatic 210 discharges. In addition, it includes electrostatic discharges which can occur from personnel to 211 objects near the equipment. 212

- 213 This standard specifies:
- 214 nominal waveform of the discharge current;
- 215 range of test levels;
- 216 test equipment; _
- 217 test setup;

_

219

218 test procedure;

calibration procedure; ttps://standards.iteh.ai)

- 220 measurement uncertainty.
- This standard gives specifications for tests performed in laboratories and guidance to post-221 222 installation tests.

This standard is not intended to specify the tests to be applied to particular apparatus or 000-4-2-2024 223 systems. The main aim is to give a general basic reference to all concerned product 224 committees. The product committees remain responsible for the appropriate choice of the 225 226 tests and the severity level to be applied to their equipment.

227 This standard excludes tests intended to evaluate the ESD sensitivity of devices during 228 handling and packaging. It is not intended for use in characterizing the performance of ESD protection circuits. 229

Normative references 230 2

231 The following referenced documents are indispensable for the application of this document. 232 For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies. 233

234 IEC 60050(161), International Electrotechnical Vocabulary (IEV) -Chapter 161: 235 Electromagnetic compatibility

3 Terms, definitions and abbreviated terms

237 **3.1 Terms and definitions**

For the purposes of this part of IEC 61000, the following terms and definitions apply and are applicable to the restricted field of electrostatic discharge; not all of them are included in IEC 60050(161) [IEV].

241 **3.1.1**

242 accessible

surfaces of the EUT which can be touched by means of the air discharge tip of the ESDgenerator

245 [SOURCE: IEC 60050-442:1998, 442-01-15, modified]

246 **3.1.2**

247 air discharge method

248 method of testing in which the charged tip of the test generator is moved towards the EUT 249 until it touches the EUT

250 3.1.3

- 251 calibration
- set of operations which establishes, by reference to standards, the relationship which exists,under specified conditions, between an indication and a result of a measurement
- 254 NOTE 1 to entry This term is based on the "uncertainty" approach.
- 255 NOTE 2 to entry The relationship between the indications and the results of measurement can be expressed, in principle, by a calibration diagram.
- 257 [SOURCE: IEC 60050-311:2001, 311-01-09]

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258 **3.1.4**

259 contact discharge method

- 260 method of testing in which the tip of the test generator is kept in contact with the EUT or 261 coupling plane and the discharge is actuated by the discharge switch within the generator
- 201 coupling plane and the discharge is actualed by the discharge Switch within the generator

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- 262 sta 3.1.5 iteh ai/catalog/standards/sist/6a29c46d-621d-4ef0-afb3-292b39eaf034/osist-pren-iec-61000-4-2-2024 coupling plane
- 264 metal sheet or plate, to which discharges are applied to simulate electrostatic discharge to 265 objects adjacent to the EUT; HCP: Horizontal Coupling Plane; VCP: Vertical Coupling Plane

266 **3.1.6**

267 degradation (in performance)

- undesired departure in the operational performance of any device, equipment or system fromits intended performance
- 270 NOTE to entry The term "degradation" can apply to temporary or permanent failure.
- 271 [SOURCE: IEC 60050-161:1990, 161-01-19]
- 272 **3.1.7**

273 direct application

274 application of the discharge directly to the EUT

275 **3.1.8**

276 electromagnetic compatibility (EMC)

- ability of equipment or a system to function satisfactorily in its electromagnetic environment
 without introducing intolerable electromagnetic disturbances to anything in that environment
- 279 [SOURCE: IEC 60050-161:2018, 161-01-07]

-9-

280 **3.1.9**

281 electrostatic discharge (ESD)

- transfer of electric charge between bodies of different electric potential in proximity or throughdirect contact
- NOTE to entry Literature and teaching generally refer to transfers of charge, although strictly speaking charge carriers (113-06-25) are transferred.
- 286 [SOURCE: IEC 60050-161:2014, 161-01-22]

287 **3.1.10**

288 energy storage capacitor

- 289 capacitor of the ESD-generator representing the capacity of a human body charged to the test 290 voltage value
- 291 NOTE to entry This element can be provided as a discrete component or a distributed capacitance.

292 3.1.11

- 293 EUT
- 294 equipment under test

295 **3.1.12**

- 296 holding time
- 297 interval of time within which the decrease of the test voltage due to leakage, prior to the 298 discharge, is not greater than 10 %

299 3.1.13

300 immunity (to a disturbance)

- 301 ability of a device, equipment or system to perform without degradation in the presence of an 302 electromagnetic disturbance
- 303 [SOURCE: IEC 60050-161:1990, 161-01-20]
- 304 **3.1.14**

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- 305 indirect application
- application of the discharge to a coupling plane in the vicinity of the EUT to simulate
 personnel discharge to objects which are adjacent to the EUT 024
- ttps://standards.iteh.ai/catalog/standards/sist/6a29c46d-621d-4ef0-afb3-292b39eaf034/osist-pren-iec-61000-4-2-202

308 **3.1.15**

309 reference ground plane (RGP)

- 310 flat conductive surface that is at the same electric potential as reference ground, which is
- 311 used as a common reference, and which contributes to a reproducible parasitic capacitance 312 with the surroundings of the equipment under test (EUT)
- 313 NOTE to entry In some regions, the term 'earth' is used in place of 'ground'.
- 314 [SOURCE: IEC 60050-161:2014, 161-04-36]

315 **3.1.16**

- 316 rise time
- interval of time between the instants at which the instantaneous value of a pulse first reachesthe specified lower and upper limits
- 319 NOTE to entry Unless otherwise specified, the lower and upper values are fixed at 10 % and 90 % of the pulse 320 magnitude.
- 321 [SOURCE: IEC 60050-161:1990, 161-02-05, modified]

322 **3.1.17**

323 verification

- 324 set of operations which is used to check the test equipment system (e.g. the test generator
- 325 and the interconnecting cables) and to gain confidence that the test system is functioning.
- 326 Details are given in 7.2.2.

327 NOTE 1 The methods used for verification can be different from those used for calibration.

NOTE 2 For the purpose of this basic EMC standard this definition is different from the definition given in IEV 311-01-13.

- 330 3.2 Abbreviated terms
- 331 AD Air Discharge
- 332 AE Auxiliary Equipment
- 333 CD Contact Discharge
- 334 EMC ElectroMagnetic Compatibility
- 335 ESD ElectroStatic Discharge
- 336 EUT Equipment Under Test
- 337 HCP Horizontal Coupling Plane
- 338 HV High Voltage
- 339 MU Measurement Uncertainty
- 340 PE Protective Earth
- 341 RGP Reference Ground Plane
- 342 VCP Vertical Coupling Plane

343 4 General

This standard relates to equipment, systems, subsystems and peripherals which can be involved in static electricity discharges as a result of environmental and installation conditions, such as low relative humidity, use of low-conductivity (artificial-fiber) carpets, synthetic-fabric garments, etc., which can exist in all locations classified in standards relevant to electrical and electronic equipment. Detailed information is specified in Annex A.

NOTE From the technical point of view, the precise term for the phenomenon would be static electricity
 discharge. However, the term electrostatic discharge (ESD) is widely used in the technical world and in technical
 literature. Therefore, it has been decided to retain the term electrostatic discharge in the title of this standard.

352 Electrostatic discharges are categorized as contact discharges and air discharges. In
 353 addition, contact discharges are categorized as direct discharges and indirect discharges.
 354 Direct discharges are applied to conductive surfaces while indirect discharges are applied to 0004-2-2024
 355 coupling planes in the vicinity of EUTs.

356 **5 Test levels**

357 The preferred range of test levels for the ESD test is specified in Table 1.

Contact discharge is the preferred test method. Air discharges shall be used where contact discharge cannot be applied. Voltages for each test method are specified in Table 1. The voltages shown are different for each method due to the differing test methods. This does not imply that the test severity is equivalent between test methods.

362 Details concerning the various parameters which can influence the voltage to which the 363 human body can be charged are given in Clause A.2. Clause A.8 also contains examples of 364 the application of the test levels related to environmental (installation) classes.

For air discharge testing, the test shall be applied at all test levels in Table 1 up to and including the specified test level. For contact discharge testing, the test shall be applied at the specified test level.

368 For further information on test level variations and applications between air and contact 369 discharge, refer to Annex A, specifically clause A.3 through clause A.7.

Table 1 – Test levels

	Test voltage	
Level	Contact discharge	Air discharge
1	2 kV	2 kV
2	4 kV	4 kV
3	6 kV	8 kV
4	8 kV	15 kV

371 NOTE Product committees can specify different test levels.

372 6 Test equipment

373 **6.1 Overview**

The ESD generator is designed to meet the characteristics in 6.2.2 and shall be calibrated in accordance with the procedure in clause 6.3 and Annex B to ensure that the intended current waveform shown in Figure 2 at the indicated voltage is delivered to the test point of the EUT or coupling plane.

378 6.2 ESD generator

379 6.2.1 General

A simplified circuit diagram of an ESD generator is shown in Figure 1. Although construction
 details (shape, size, weight, materials, etc.) of the generator are not specified, the following
 main items are used in the design of an ESD generator:

- 383 charging resistor R_c ;
- energy-storage capacitor C_s ;
- 385 distributed capacitance C_d ;
- 386 discharge resistor R_d ;
- 387 voltage indicator;
- 388 discharge switch;
- 389 charge switch;

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¹¹¹ 390 ^{stan_ta} interchangeable discharge tips (see Figure 3 and Figure 4);^{92b39eaf034/osist-pren-iec-61000-4-2-2024}

- 391 discharge return cable;
- 392 power supply unit.



393

394 Components

- $\begin{array}{ccc} 395 & C_{\rm d} & \text{ is a distributed capacitance which exists between the generator and its} \\ 396 & \text{ surroundings.} \end{array}$
- 397 $C_{\rm s} + C_{\rm d}$ has a typical value of 150 pF.
- 398 $R_{\rm d}$ has a typical value of 330 Ω .

399

Figure 1 – Simplified diagram of the ESD generator

400 The ESD generator shall meet the requirements specified in 6.2.2 and indicated in Figure 2 401 when evaluated according to the procedures in 6.3. Therefore, neither the diagram in 402 Figure 1, nor the component values are specified in detail.





404

406

Figure 2 – Ideal contact discharge current waveform at 4 kV

405 An equation to generate the waveform in Figure 2, I(t), is as follows:

$$I(t) = \frac{I_1}{k_1} \times \frac{\left(\frac{t}{\tau_1}\right)^n}{1 + \left(\frac{t}{\tau_1}\right)^n} \times \exp\left(\frac{-t}{\tau_2}\right) + \frac{I_2}{k_2} \times \frac{\left(\frac{t}{\tau_3}\right)^n}{1 + \left(\frac{t}{\tau_3}\right)^n} \times \exp\left(\frac{-t}{\tau_4}\right)$$

$$k_1 = \exp\left(-\frac{\tau_1}{\tau_2} \left(\frac{n \tau_2}{\tau_1}\right)^{1/n}\right)$$

$$k_2 = \exp\left(-\frac{\tau_3}{\tau_4} \left(\frac{n\tau_4}{\tau_3}\right)^{1/n}\right)$$

- 410 and
- 411 $\tau_1 = 1,1 \text{ ns}; \tau_2 = 2,0 \text{ ns}; \tau_3 = 12,0 \text{ ns}; \tau_4 = 37,0 \text{ ns};$
- 412 $I_1 = 16,6 \text{ A} (\text{at 4 kV}); I_2 = 9,3 \text{ A} (\text{at 4 kV});$
- 413 n = 1,8.

414 6.2.2 General characteristics

415 6.2.2.1 Specifications of the ESD generator

The parameters of the ESD generator are specified in Table 2 and Table 3.